



IAUS300N08S5N011

OptiMOS™-5 Power-Transistor



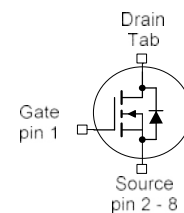
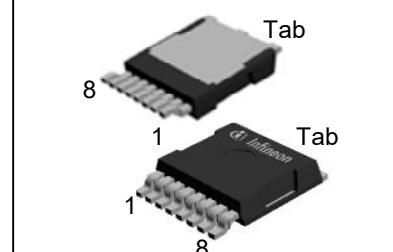
Features

- OptiMOS™ power MOSFET for automotive applications
- N-channel – Enhancement mode – Normal Level
- Extended qualification beyond AEC-Q101
- Enhanced electrical testing
- Robust design
- MSL1 up to 260°C peak reflow
- 175°C operating temperature
- Green product (RoHS compliant)
- 100% Avalanche tested

Product Summary

V_{DS}	80	V
$R_{DS(on)}$	1.1	mΩ
I_D	300	A

PG-HSOG-8-1



Type	Package	Marking
IAUS300N08S5N011	PG-HSOG-8-1	A08S5N11

Maximum ratings, at $T_J=25\text{ °C}$, unless otherwise specified

Parameter	Symbol	Conditions	Value	Unit
Continuous drain current	I_D	$V_{GS}=10\text{ V}$, Chip limitation ^{1,2)}	410	A
		$V_{GS}=10\text{ V}$, DC current ³⁾	300	
		$T_a=85\text{ °C}$, $V_{GS}=10\text{ V}$, R_{thJA} on 2s2p ^{2,4)}	52	
Pulsed drain current ²⁾	$I_{D,pulse}$	$T_C=25\text{ °C}$, $t_p=100\text{ }\mu\text{s}$	1505	
Avalanche energy, single pulse ²⁾	E_{AS}	$I_D=150\text{ A}$	817	mJ
Avalanche current, single pulse	I_{AS}	-	300	A
Gate source voltage	V_{GS}	-	±20	V
Power dissipation	P_{tot}	$T_C=25\text{ °C}$	375	W
Operating and storage temperature	T_j, T_{stg}	-	-55 ... +175	°C
IEC climatic category; DIN IEC 68-1	-	-	55/175/56	

Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	

Thermal characteristics²⁾

Thermal resistance, junction - case	R_{thJC}		-	-	0.4	K/W
Thermal resistance, junction - ambient ⁴⁾	R_{thJA}		-	14.8	-	

Electrical characteristics, at $T_j=25^\circ\text{C}$, unless otherwise specified
Static characteristics

Drain-source breakdown voltage	$V_{(BR)DSS}$	$V_{GS}=0\text{ V}, I_D=1\text{ mA}$	80	-	-	V
Gate threshold voltage	$V_{GS(th)}$	$V_{DS}=V_{GS}, I_D=275\text{ }\mu\text{A}$	2.2	3	3.8	
Zero gate voltage drain current	I_{DSS}	$V_{DS}=80\text{ V}, V_{GS}=0\text{ V}, T_j=25^\circ\text{C}$	-	0.1	1	μA
		$V_{DS}=50\text{ V}, V_{GS}=0\text{ V}, T_j=85^\circ\text{C}^{2)}$	-	1	20	
Gate-source leakage current	I_{GSS}	$V_{GS}=20\text{ V}, V_{DS}=0\text{ V}$	-	-	100	nA
Drain-source on-state resistance	$R_{DS(on)}$	$V_{GS}=6\text{ V}, I_D=75\text{ A}$	-	1.3	1.7	m Ω
		$V_{GS}=10\text{ V}, I_D=100\text{ A}$	-	1.0	1.1	
Gate resistance ²⁾	R_G	-	-	1.5	-	Ω



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Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	

Dynamic characteristics²⁾

Input capacitance	C_{iss}	$V_{GS}=0\text{ V}, V_{DS}=40\text{ V},$ $f=1\text{ MHz}$	-	12500	16250	pF
Output capacitance	C_{oss}		-	2000	2600	
Reverse transfer capacitance	C_{rss}		-	86	130	
Turn-on delay time	$t_{d(on)}$	$V_{DD}=40\text{ V}, V_{GS}=10\text{ V},$ $I_D=100\text{ A}, R_G=3.5\ \Omega$	-	31	-	ns
Rise time	t_r		-	19	-	
Turn-off delay time	$t_{d(off)}$		-	69	-	
Fall time	t_f		-	55	-	

Gate Charge Characteristics²⁾

Gate to source charge	Q_{gs}	$V_{DD}=40\text{ V}, I_D=100\text{ A},$ $V_{GS}=0\text{ to }10\text{ V}$	-	56	73	nC
Gate to drain charge	Q_{gd}		-	37	56	
Gate charge total	Q_g		-	178	231	
Gate plateau voltage	$V_{plateau}$		-	4.5	-	V

Reverse Diode

Diode continuous forward current ²⁾	I_S	$T_C=25\text{ °C}$	-	-	300	A
Diode pulse current ²⁾	$I_{S,pulse}$	$T_C=25\text{ °C}$	-	-	1505	
Diode forward voltage	V_{SD}	$V_{GS}=0\text{ V}, I_F=100\text{ A},$ $T_J=25\text{ °C}$	-	0.9	1.2	V
Reverse recovery time ²⁾	t_{rr}	$V_R=40\text{ V}, I_F=50\text{ A},$ $di_F/dt=100\text{ A}/\mu\text{s}$	-	86	-	ns
Reverse recovery charge ²⁾	Q_{rr}		-	177	-	nC

¹⁾ Practically the current is limited by the overall system design including the customer-specific PCB.

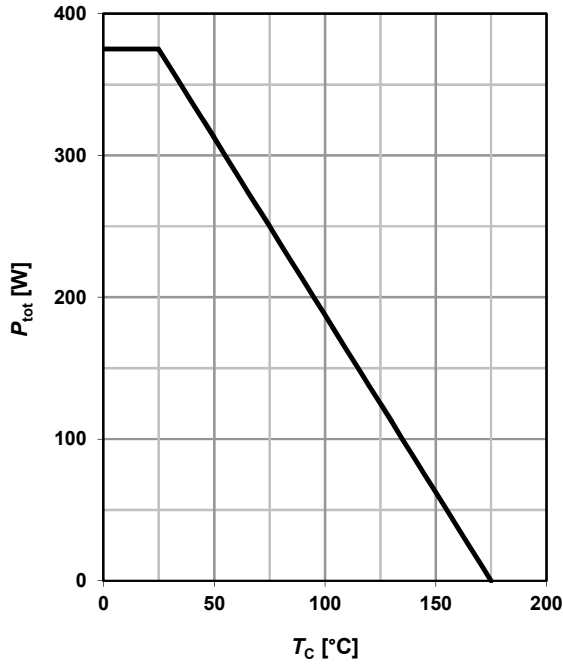
²⁾ The parameter is not subject to production testing – specified by design.

³⁾ Current is limited by the bondwires.

⁴⁾ Device on 2s2p FR4 PCB defined in accordance with JEDEC standards (JESD51-5, -7). PCB is vertical in still air.

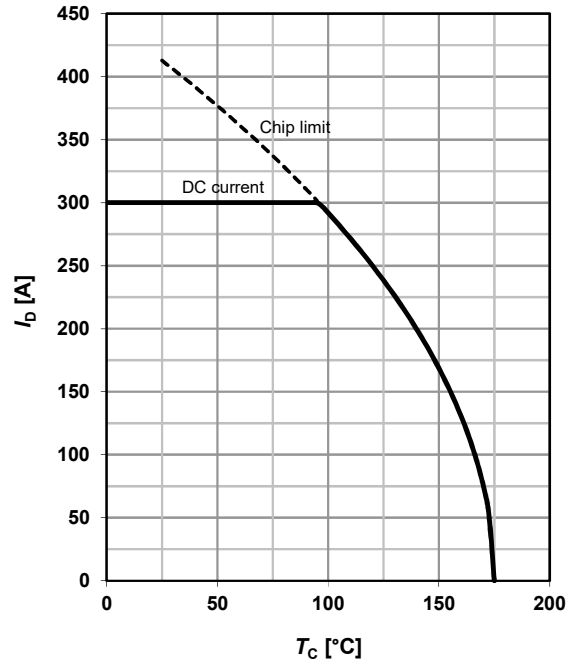
1 Power dissipation

$$P_{\text{tot}} = f(T_C); V_{\text{GS}} \geq 6 \text{ V}$$



2 Drain current

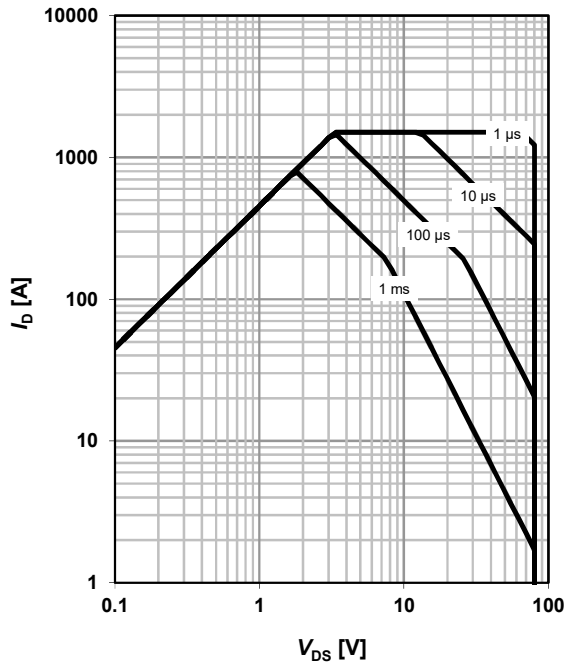
$$I_D = f(T_C); V_{\text{GS}} \geq 6 \text{ V}$$



3 Safe operating area

$$I_D = f(V_{\text{DS}}); T_C = 25^\circ\text{C}; D = 0$$

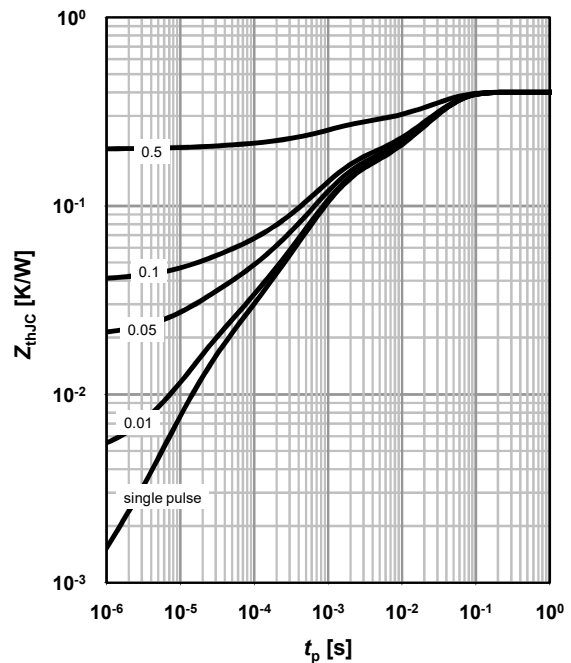
parameter: t_p



4 Max. transient thermal impedance

$$Z_{\text{thJC}} = f(t_p)$$

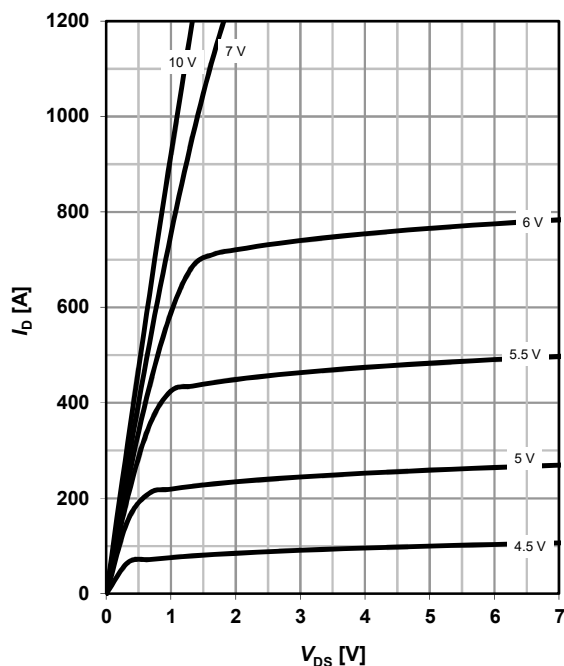
parameter: $D = t_p/T$



5 Typ. output characteristics

$$I_D = f(V_{DS}); T_j = 25^\circ\text{C}$$

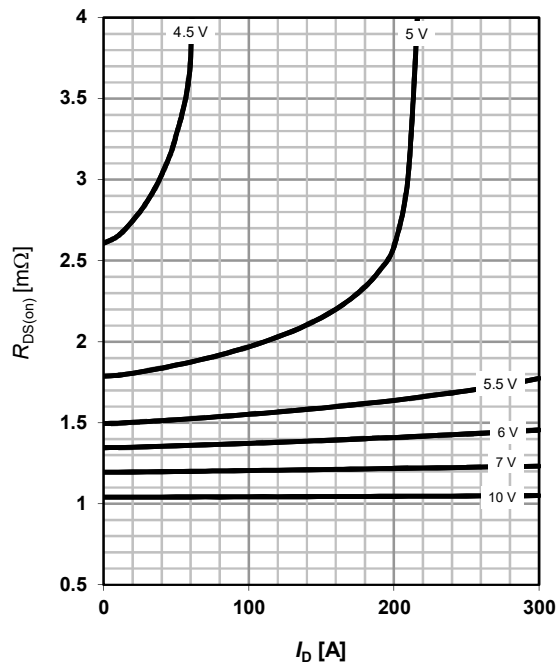
parameter: V_{GS}



6 Typ. drain-source on-state resistance

$$R_{DS(on)} = f(I_D); T_j = 25^\circ\text{C}$$

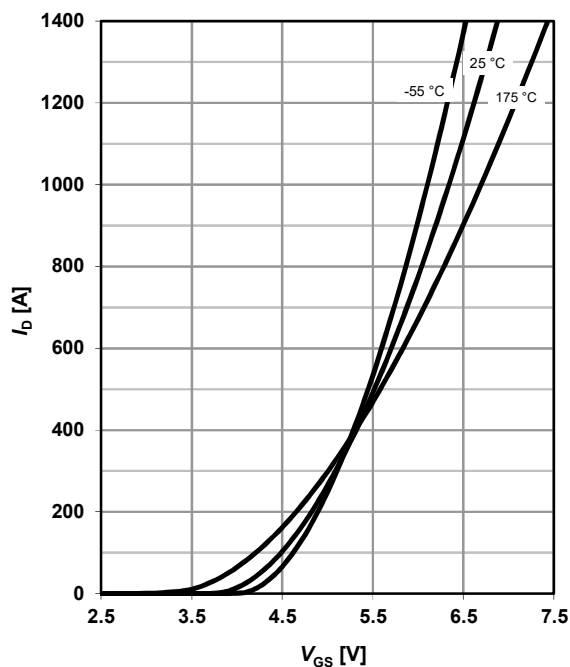
parameter: V_{GS}



7 Typ. transfer characteristics

$$I_D = f(V_{GS}); V_{DS} = 6\text{ V}$$

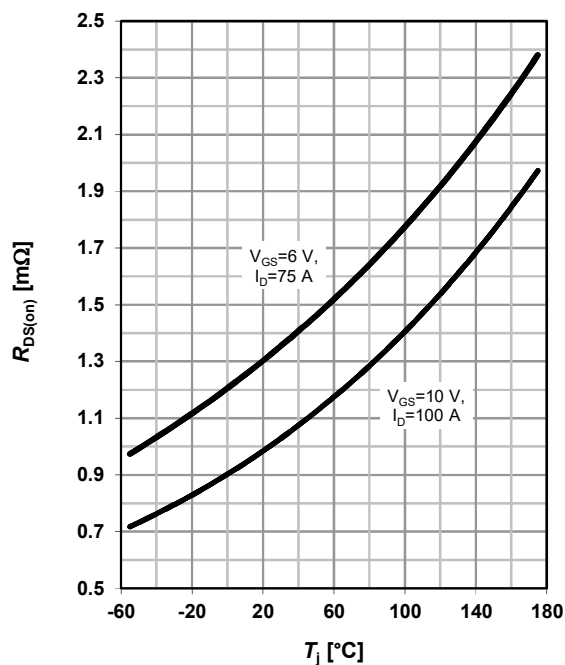
parameter: T_j



8 Typ. drain-source on-state resistance

$$R_{DS(on)} = f(T_j)$$

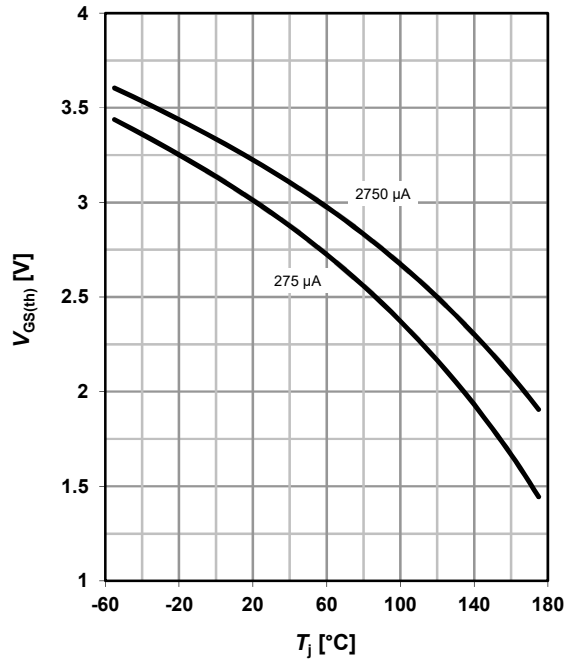
parameter: I_D, V_{GS}



9 Typ. gate threshold voltage

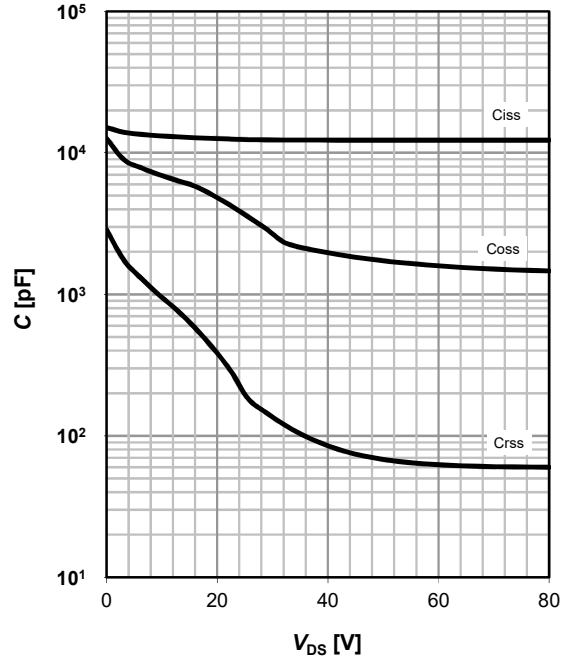
$$V_{GS(th)} = f(T_j); V_{GS} = V_{DS}$$

parameter: I_D



10 Typ. capacitances

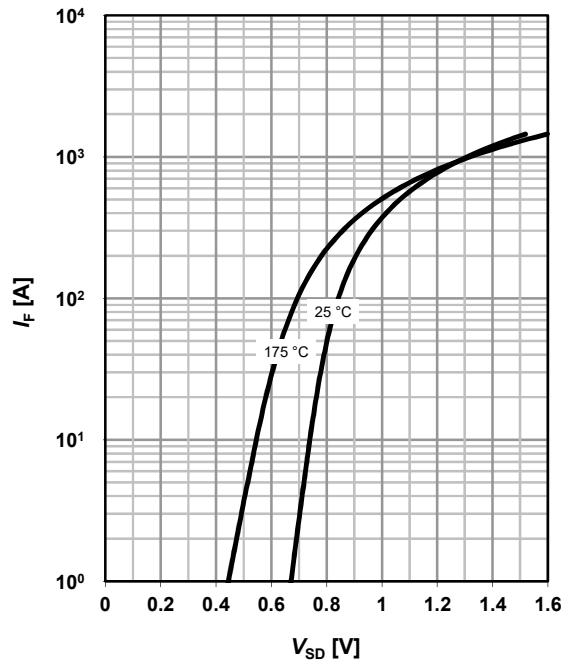
$$C = f(V_{DS}); V_{GS} = 0 V; f = 1 MHz$$



11 Typical forward diode characteristics

$$I_F = f(V_{SD})$$

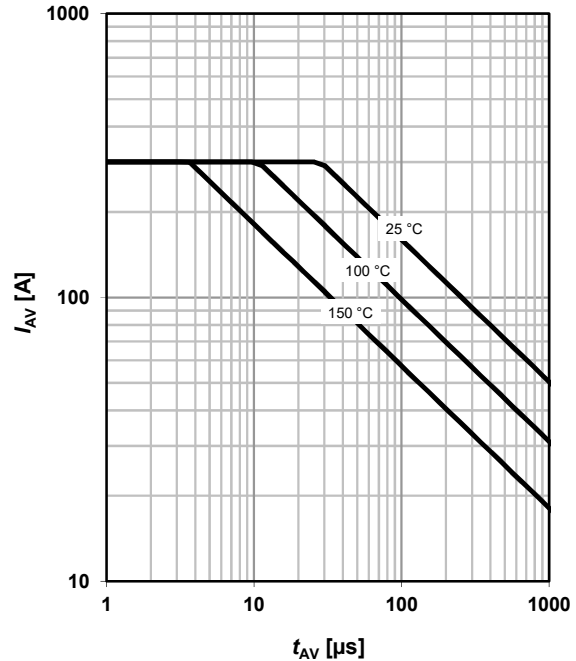
parameter: T_j



12 Typ. avalanche characteristics

$$I_{AS} = f(t_{AV})$$

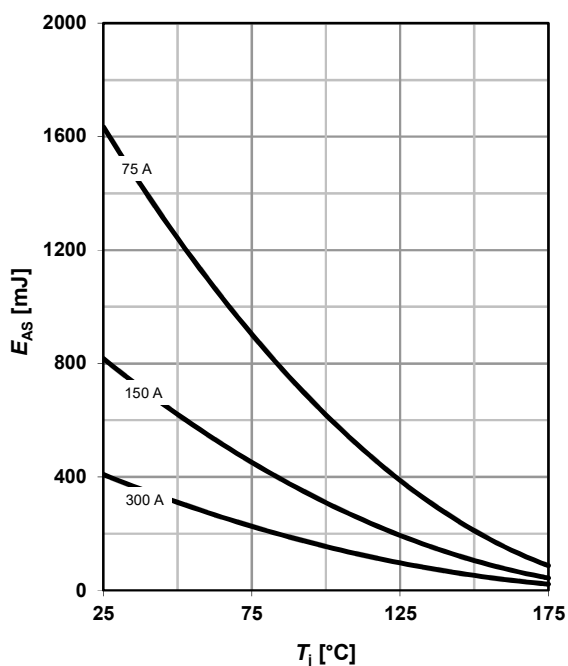
parameter: $T_{j(start)}$



13 Typical avalanche energy

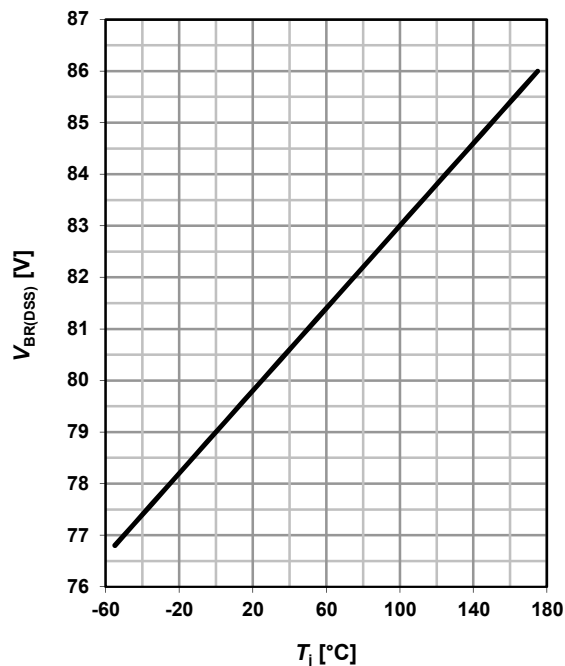
$$E_{AS} = f(T_j)$$

parameter: I_D



14 Drain-source breakdown voltage

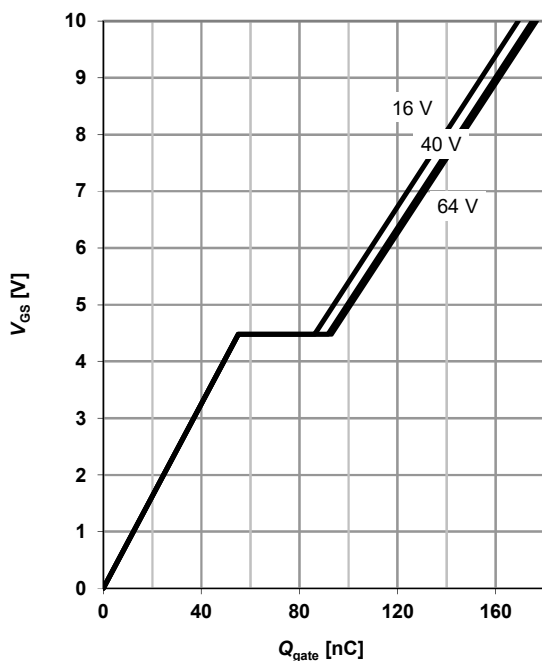
$$V_{BR(DSS)} = f(T_j); I_{D_typ} = 1 \text{ mA}$$



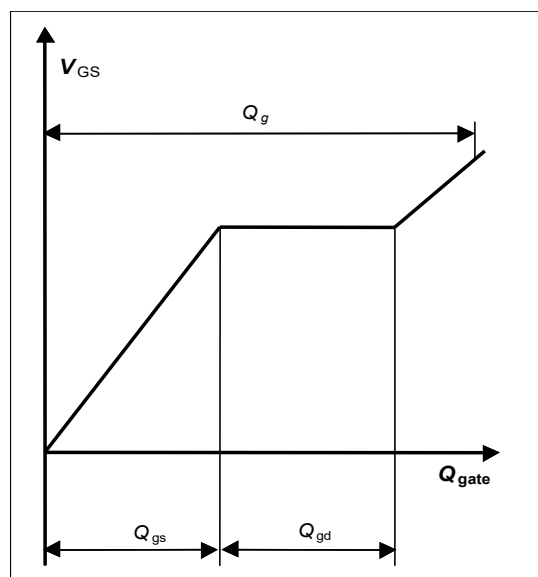
15 Typ. gate charge

$$V_{GS} = f(Q_{gate}); I_D = 100 \text{ A pulsed}$$

parameter: V_{DD}



16 Gate charge waveforms



TOP VIEW

Dimensions: 9.75, 0.7 $\pm$ 0.2, 1.2, 3x, 3.08, 2x, Ø3, 8.55 $\pm$ 0.1, (2.64) (3.02), 9.9 $\pm$ 0.2, 2.45

BOTTOM VIEW

Dimensions: (9.46), 8.3, 3.6, (3.02), 0.65, 6.91, (7.01), 2.54 $\pm$ 0.1, 0.7, 8x, 1.2, 7 x 1.20 = 8.4, 0.5, 7x

SIDE VIEW

Dimensions: 2.3, 3.3, 11.7 $\pm$ 0.2, 0.76, 0...0.1, 0.5

All dimensions are in units mm
 The drawing is in compliance with ISO 128-30, Projection Method 1 [1 $\times$]

Figure 1: Dimensions of the PCB layout. The figure consists of two parts: (a) Top view and (b) Side view. Part (a) shows a top view of the PCB with dimensions: overall width 10.1, overall height 6.625, copper pad width 0.7, solder mask thickness 1.55, solder mask width 2.75, solder mask height 3.7, solder mask thickness 2.8, solder mask width 0.9, solder mask height 0.6, and solder mask width 1.2. Part (b) shows a side view of the PCB with dimensions: solder mask thickness 0.85, solder mask width 4x, solder mask height 0.5, solder mask width 0.25, solder mask height 0.7, solder mask width 4x, solder mask height 6.525, solder mask width 4.5, solder mask height 6x, solder mask width 1.1, solder mask height 5, solder mask width 2.7, solder mask height 0.8, solder mask width 1.2, and solder mask height 0.6.



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Revision History

Version	Date	Changes
Version 1.0	2021-01-19	Final Datasheet
Version 1.1	2021-01-26	Part Marking Info corrected